

Product data sheet

Product profile 1.

1.1 General description

N-channel enhancement mode Field-Effect Transistor (FET) in a SOT23 (TO-236AB) small Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

1.2 Features and benefits

- Very fast switching
- Low threshold voltage

Trench MOSFET technology

1.3 Applications

- Battery-powered motor control
- High-speed switching in set top box power supplies

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	-	20	V
I _D	drain current	$T_{sp} = 25 ^{\circ}\text{C}$; $V_{GS} = 4.5 \text{V}$; see Figure 2; see Figure 3	-	-	5.9	Α
P _{tot}	total power dissipation	T _{sp} = 25 °C; see <u>Figure 1</u>	-	-	2	W
Static characte	eristics					
R _{DSon}	drain-source on-state resistance	$V_{GS} = 2.5 \text{ V}; I_D = 1 \text{ A}; T_j = 25 ^{\circ}\text{C}; \text{ see}$ Figure 9; see Figure 10	-	44	53	mΩ
		$V_{GS} = 4.5 \text{ V}; I_D = 1.5 \text{ A}; T_j = 25 \text{ °C}; \text{ see}$ Figure 9; see Figure 10	-	31	37	mΩ



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		0
2	S	source		
3	D	drain	1 2	G (FA)
			SOT23 (TO-236AB)	Š 017aaa253

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
PMV31XN	TO-236AB	plastic surface-mounted package; 3 leads	SOT23

4. Marking

Table 4. Marking codes

Type number	Marking code[1]
PMV31XN	%M4

^{[1] % =} placeholder for manufacturing site code

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 150 °C	-	20	V
V_{DGR}	drain-gate voltage	$T_j \ge 25$ °C; $T_j \le 150$ °C; $R_{GS} = 20$ kΩ	-	20	V
V _{GS}	gate-source voltage		-12	12	V
I _D	drain current	$T_{sp} = 100 \text{ °C}; V_{GS} = 4.5 \text{ V}; \text{ see } \frac{\text{Figure 2}}{\text{Model}}$	-	3.75	Α
		T_{sp} = 25 °C; V_{GS} = 4.5 V; see <u>Figure 2</u> ; see <u>Figure 3</u>	-	5.9	Α
I _{DM}	peak drain current	T_{sp} = 25 °C; pulsed; $t_p \le 10 \mu s$; see Figure 3	-	23.7	Α
P _{tot}	total power dissipation	T _{sp} = 25 °C; see <u>Figure 1</u>	-	2	W
T _{stg}	storage temperature		-55	150	°C
Tj	junction temperature		-55	150	°C
Source-drain	diode				
Is	source current	T _{sp} = 25 °C	-	1.7	Α

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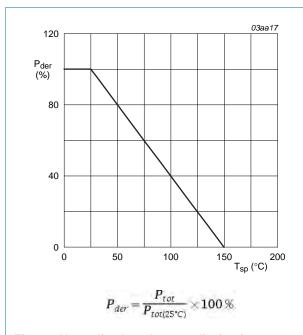


Fig 1. Normalized total power dissipation as a function of solder point temperature

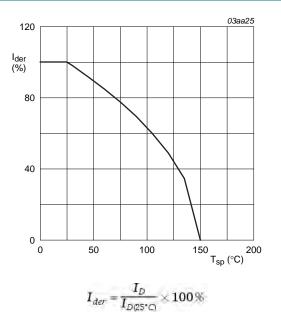


Fig 2. Normalized continuous drain current as a function of solder point temperature

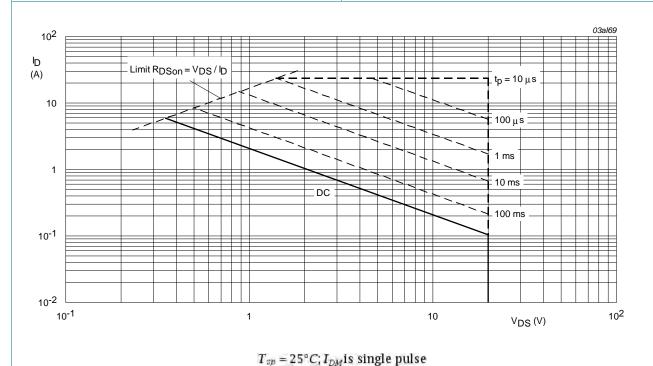


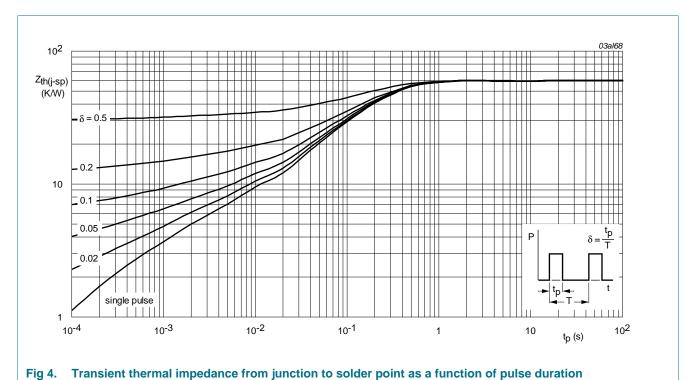
Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

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6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	N	/lin	Тур	Max	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point	see Figure 4	-		-	60	K/W



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7. Characteristics

Table 7. Characteristics

Table 7.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 °C$	18	-	-	V
	breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 °C$	20	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = -55 \text{ °C}$; see Figure 8	-	-	1.8	V
		$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 150 \text{ °C}$; see Figure 8	0.35	-	-	V
		$I_D = 1 \text{ mA}$; $V_{DS} = V_{GS}$; $T_j = 25 \text{ °C}$; see Figure 8	0.5	-	1.5	V
I_{DSS}	drain leakage current	$V_{DS} = 20 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$	-	-	100	μΑ
		$V_{DS} = 20 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	-	1	μΑ
I_{GSS}	gate leakage current	$V_{GS} = 12 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nA
		$V_{GS} = -12 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nΑ
R _{DSon}	drain-source on-state resistance	$V_{GS} = 2.5 \text{ V}; I_D = 1 \text{ A}; T_j = 25 ^{\circ}\text{C}; \text{ see}$ Figure 9; see Figure 10	-	44	53	mΩ
		$V_{GS} = 4.5 \text{ V}$; $I_D = 1.5 \text{ A}$; $T_j = 25 \text{ °C}$; see Figure 9; see Figure 10	-	31	37	mΩ
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 6 \text{ A}; V_{DS} = 10 \text{ V}; V_{GS} = 4.5 \text{ V};$	-	5.8	-	nC
Q_{GS}	gate-source charge	T _j = 25 °C; see <u>Figure 11</u>	-	1.4	-	nC
Q_{GD}	gate-drain charge		-	1.7	-	nC
C _{iss}	input capacitance	$V_{DS} = 20 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	410	-	pF
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 12</u>	-	115	-	pF
C _{rss}	reverse transfer capacitance		-	80	-	pF
t _{d(on)}	turn-on delay time	V_{DS} = 10 V; R_L = 10 Ω ; V_{GS} = 4.5 V;	-	10	-	ns
t _r	rise time	$R_{G(ext)} = 6 \Omega; T_j = 25 °C$	-	15	-	ns
t _{d(off)}	turn-off delay time		-	25	-	ns
t _f	fall time		-	12	-	ns
Source-d	rain diode					
V_{SD}	source-drain voltage	$I_S = 1.5 \text{ A}$; $V_{GS} = 0 \text{ V}$; $T_j = 25 ^{\circ}\text{C}$; see Figure 13	-	0.75	1.2	V

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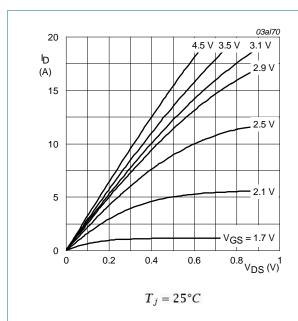


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

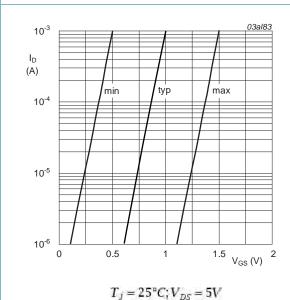
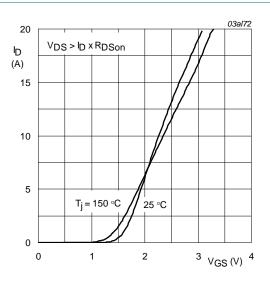
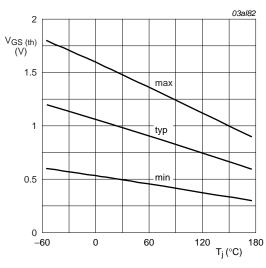


Fig 7. Sub-threshold drain current as a function of gate-source voltage



 $T_{j} = 25$ °C and 150°C; $V_{DS} > I_{D} \times R_{DSON}$

Fig 6. Transfer characteristics: drain current as a function of gate-source voltage; typical values



 $I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 8. Gate-source threshold voltage as a function of junction temperature

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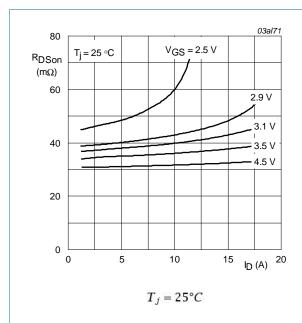


Fig 9. Drain-source on-state resistance as a function of drain current; typical values

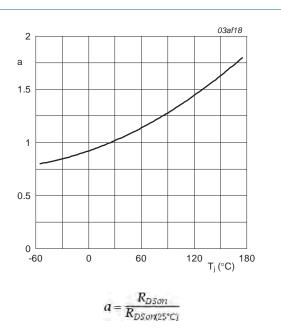


Fig 10. Normalized drain-source on-state resistance factor as a function of junction temperature

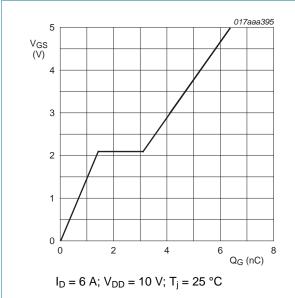


Fig 11. Gate-source voltage as a function of gate charge; typical values

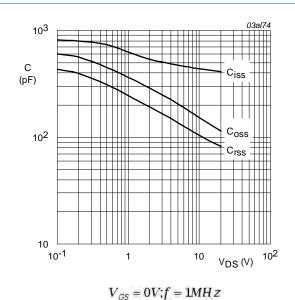
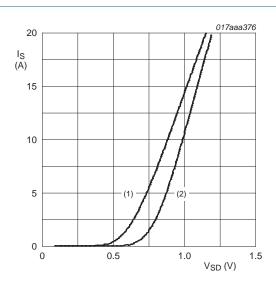


Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

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 $V_{DS} > I_D \times R_{DSon}$

(1) T_j = 25 °C

(2) $T_j = 150 \, ^{\circ}\text{C}$

Fig 13. Source current as a function of source-drain voltage; typical values

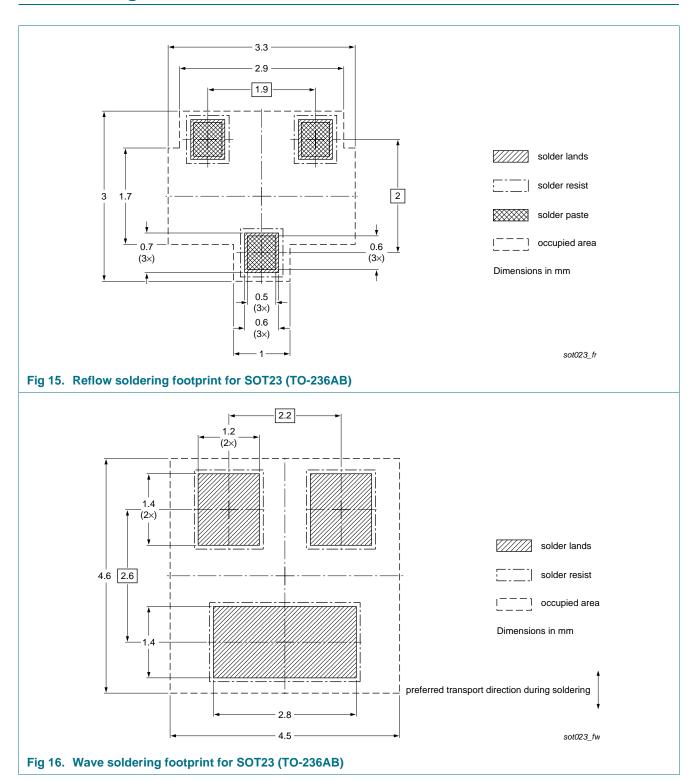
8. Package outline

Plastic surface-mounted package; 3 leads SOT23 В Χ = v M A 3 2 **→** | w (M) B е detail X DIMENSIONS (mm are the original dimensions) A_1 H_E $\mathbf{L}_{\mathbf{p}}$ UNIT С Ε Α b_p е e₁ w 0.48 0.15 3.0 0.45 1.9 0.95 0.2 0.1 0.9 0.38 2.8 1.2 REFERENCES OUTLINE EUROPEAN ISSUE DATE VERSION **PROJECTION** IEC **JEDEC** JEITA 04-11-04 SOT23 TO-236AB 06-03-16

Fig 14. Package outline SOT23 (TO-236AB)

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9. Soldering



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10. Revision history

Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
PMV31XN v.2	20111130	Product data sheet	-	PMV31XN v.1		
Modifications:	 The format of the NXP Semicon 		esigned to comply with t	he new identity guidelines of		
	 Legal texts have been adapted to the new company name where appropriate. 					
	<u>1 "Product profile"</u> : updated					
	 <u>5 "Limiting values"</u>: V_{DSR} drain-source voltage redefined to V_{DGR} drain-gate voltage 					
	 14 "Package outline SOT23 (TO-236AB)": updated 					
	• <u>9 "Soldering"</u> : added					
	• 11 "Legal information": updated					
PMV31XN v.1	20030226	Product data sheet	-	-		

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11. Legal information

11.1 Data sheet status

Document status [1] [2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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